

**Search Notes****Application/Control No.**

10/074,174

**Examiner**

Hanh Nguyen

**Applicant(s)/Patent under Reexamination**

LU, HAW-MINN

**Art Unit**

2616

**SEARCHED**

Class	Subclass	Date	Examiner
370	388	6/20/2006	HN
	254		
	367		
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370	400		
370	389		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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**INTERFERENCE SEARCHED**

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